

STI150N10F7, STP150N10F7

N-channel 100 V, 0.0036 Ω typ., 110 A, STripFET™ F7 Power MOSFETs in I²PAK and TO-220 packages

Datasheet - production data

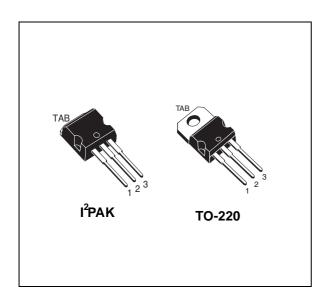
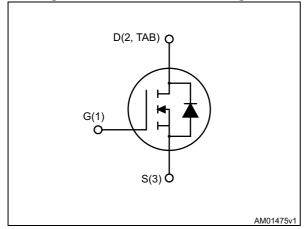


Figure 1. Internal schematic diagram



Features

Order codes	V _{DS}	R _{DS(on)max}	I _D	P _{TOT}
STI150N10F7	100 V	0.0042 Ω	110 Δ	250 W
STP150N10F7	100 V	0.0042 32	110 A	230 W

- Among the lowest R_{DS(on)} on the market
- Excellent figure of merit (FoM)
- Low Crss/Ciss ratio for EMI immunity
- High avalanche ruggedness

Applications

· Switching applications

Description

These N-channel Power MOSFETs utilize STripFET™ F7 technology with an enhanced trench gate structure that results in very low onstate resistance, while also reducing internal capacitance and gate charge for faster and more efficient switching.

Table 1. Device summary

Order codes	Marking	Package	Packaging
STI150N10F7	150N10F7	I ² PAK	Tube
STP150N10F7	100141017	TO-220	Tabe

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1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage	100	V
V _{GS}	Gate- source voltage	±20	V
I _D	Drain current (continuous) at T _C = 25 °C	110	А
I _D	Drain current (continuous) at T _C = 100 °C	110	А
I _{DM} ⁽¹⁾	Drain current (pulsed)	440	А
P _{TOT}	Total dissipation at T _C = 25 °C	250	W
E _{AS} ⁽²⁾	Single pulse avalanche energy	495	mJ
TJ	Operating junction temperature	e -55 to 175	
T _{stg}	Storage temperature	-55 to 175	°C

^{1.} Pulse width is limited by safe operating area

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	0.6	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	62.5	°C/W

^{2.} Starting T_j =25 °C, I_D =30 A, V_{DD} =50 V

2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Table 4. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0$, $I_D = 250 \mu A$	100			V
	Zero gate voltage	$V_{GS} = 0, V_{DS} = 100 \text{ V}$			1	μΑ
I _{DSS}	drain current	V _{GS} = 0, V _{DS} = 100 V, T _C =125 °C			100	μΑ
I _{GSS}	Gate-body leakage current	V _{DS} = 0, V _{GS} = +20 V			100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.5		4.5	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 55 A		0.0036	0.0042	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	8115	-	pF
C _{oss}	Output capacitance	V _{DS} = 50 V, f = 1 MHz,	-	1510	-	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0$	-	67	-	pF
Qg	Total gate charge	V _{DD} = 50 V, I _D = 110 A,	-	117	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	47	-	nC
Q _{gd}	Gate-drain charge	(see Figure 14)	-	26	-	nC

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time		-	33	-	ns
t _r	Rise time	$V_{DD} = 50 \text{ V}, I_{D} = 55 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 13</i>)	-	57	-	ns
t _{d(off)}	Turn-off delay time		-	72	-	ns
t _f	Fall time		-	33	-	ns



Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		110	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		440	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 110 A, V _{GS} = 0	-		1.2	V
t _{rr}	Reverse recovery time	I _{SD} = 110 A, di/dt = 100 A/μs	-	70		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 80 V, T _J =150 °C	-	165		nC
I _{RRM}	Reverse recovery current	(see Figure 15)	1	4.7		Α

^{1.} Pulse width limited by safe operating area

^{2.} Pulsed: pulse duration = 300 μ s, duty cycle 1.5%.

Electrical characteristics (curves) 2.1

Figure 2. Safe operating area

AM18051v1 ID (A) 100 10 100µs 1ms 10ms Tc=25°C Single pulse 10 VDS(V)

Figure 3. Thermal impedance

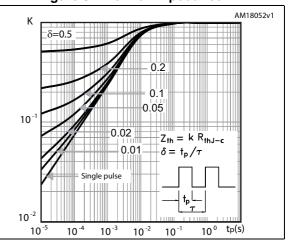
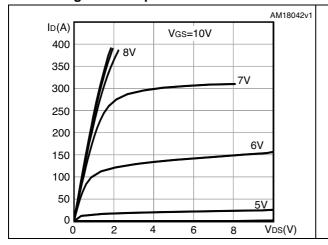


Figure 4. Output characteristics

Figure 5. Transfer characteristics



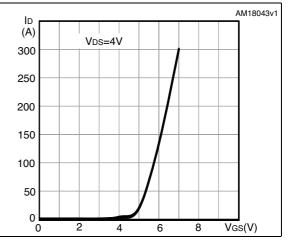
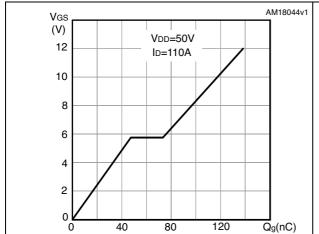
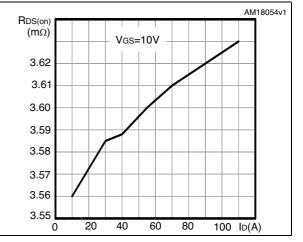


Figure 6. Gate charge vs gate-source voltage

Figure 7. Static drain-source on-resistance

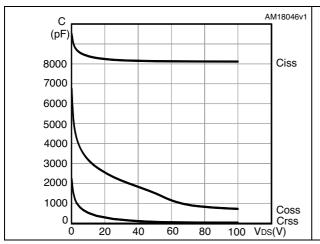




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Figure 8. Capacitance variations

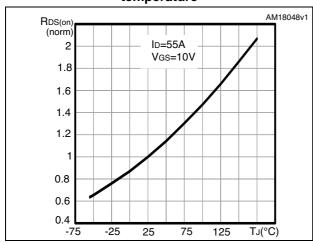
Figure 9. Normalized gate threshold voltage vs temperature



VGS(th) (norm)
1.1
1
0.9
0.8
0.7
0.6
0.5
0.4
-75 -25 25 75 125 TJ(°C)

Figure 10. Normalized on-resistance vs temperature

Figure 11. Normalized $V_{(BR)DSS}$ vs temperature



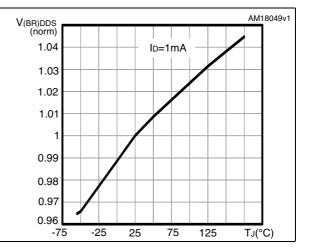
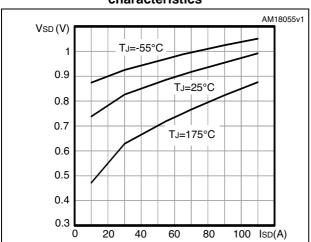


Figure 12. Source-drain diode forward characteristics



3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

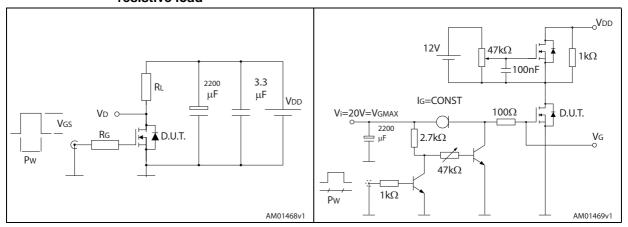


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped inductive load test circuit

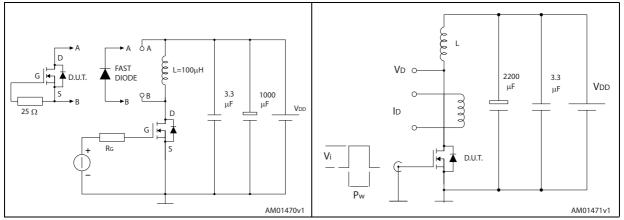
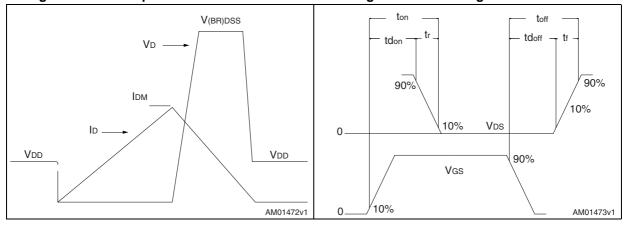


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



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4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.



 $\begin{array}{c} L2 \\ \\ D \\$

Figure 19. I²PAK (TO-262) drawing

Table 8. I²PAK (TO-262) mechanical data

DIM.		mm.	
DIWI.	min.	typ	max.
Α	4.40		4.60
A1	2.40		2.72
b	0.61		0.88
b1	1.14		1.70
С	0.49		0.70
c2	1.23		1.32
D	8.95		9.35
е	2.40		2.70
e1	4.95		5.15
Е	10		10.40
L	13		14
L1	3.50		3.93
L2	1.27		1.40

øΡ Ε H1 D <u>D1</u> L20 L30 b1(X3) -- b (X3) _e1___ 0015988_typeA_Rev_T

Figure 20. TO-220 type A drawing

Table 9. TO-220 type A mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
А	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
С	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
е	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95

5 Revision history

Table 10. Document revision history

Date	Revision	Changes
16-Apr-2013	1	First release.
22-Jan-2014	2	 The part number STH150N10F7-2 has been moved to a separate datasheet Added: I²PAK package Modified: Figure 1 Modified: I_D and I_{DM} values in Table 2 Modified: R_{thj-case} value in Table 3 Modified: R_{DS(on)} values in Table 4 Modified: V_{SD}, I_D and the entire typical values in Table 5, 6 and 7 Updated: Figure 13, 14, 15 and 16 Updated: Section 4: Package mechanical data Added: Section 2.1: Electrical characteristics (curves) Minor text changes
24-Feb-2014	3	 Datasheet status promoted from preliminary data to production data Modified: Figure 10 Minor text changes
20-Aug-2014		 Updated title, features and description in cover page. Added E_{AS} parameter in <i>Table 2: Absolute maximum ratings</i>. Minor text changes

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